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Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/820,098	PATEL ET AL.	
Examiner	Art Unit	
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SEARCHED				
Class	Subclass	Date	Examiner	
385	16	3/4/2006	DMH	
398	45	3/4/2006	DMH	
359	341.3	3/4/2006	DMH	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East text search: see attached strategy double patenting foreign IEEE	314106	<b>18</b>
updated search	7/13/06	105
updated search.		